

Search Notes



Application/Control No.

09/809,332

Examiner

DANG T. TON

Applicant(s)/Patent under
Reexamination

HEIN ET AL.

Art Unit

2666

SEARCHED

Class	Subclass	Date	Examiner
<i>updated</i>		<i>11/16/05</i>	<i>F.D</i>

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR